



P-Channel 1.5-V (G-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)		
	0.041 at V _{GS} = - 4.5 V	- 10.0			
- 20	0.048 at V _{GS} = - 2.5 V	- 9.32	22 nC		
- 20	0.058 at V _{GS} = - 1.8 V	- 8.48	22110		
	0.075 at V _{GS} = - 1.5 V	- 7.45			

FEATURES

• TrenchFET® Power MOSFET



Ultra Small MICRO FOOT[®] Chipscale
 Packaging Reduces Footprint Area, Profile
 (0.62 mm) and On-Resistance Per Footprint Area

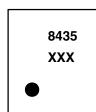
RoHS

APPLICATIONS

- · Low Threshold Load Switch for Portable Devices
 - Low Power Consumption
 - Increased Battery Life

MICRO FOOT

Bump Side View

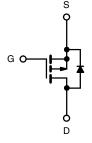


Backside View

Device Marking: 8435

xxx = Date/Lot Traceability Code

Ordering Information: Si8435DB-T1-E1 (Lead (Pb)-free)



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	- 20	V	
Gate-Source Voltage		V_{GS}	± 5	V	
	T _C = 25 °C		- 10.0		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C		- 8.06	7	
Continuous Dialit Current (1) = 130 °C)	T _A = 25 °C	I _D	- 6.72 ^{b,c}		
	T _A = 70 °C		- 5.37 ^{b,c}	Α	
Pulsed Drain Current		I _{DM}	- 15	1	
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	- 5.21		
Continuous Source-Diain Diode Current	T _A = 25 °C	I _S	- 2.31 ^{b,c}		
	T _C = 25 °C		6.25		
Maximum Power Dissipation	T _C = 70 °C	P _D	4.0	W	
Maximum Fower Dissipation	T _A = 25 °C	' Б	2.78 ^{b,c}	VV	
	T _A = 70 °C		1.78 ^{b,c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Package Reflow Conditions ^d	IR/Convection		260	C	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Refer to IPC/JEDEC (J-STD-020C), no manual or hand soldering.
- e. In this document, any reference to the Case represents the body of the MICRO FOOT device and Foot is the bump.



THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a,b}	R _{thJA}	35	45	°C/W		
Maximum Junction-to-Foot (Drain) Steady State		R _{thJF}	16	20	J 5/ VV	

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. Maximum under Steady State conditions is 72 $^{\circ}\text{C/W}.$

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	<u>, </u>		<u>'</u>		<u>'</u>		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 15.5		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = - 250 μΑ		2.5		mv/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.35		- 1.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$			± 100	nA	
Zara Cata Valtaga Drain Current	1	V _{DS} = - 20 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} = - 20 V, V_{GS} = 0 V , T_J = 70 °C			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 4.5 V	- 15			Α	
		V _{GS} = - 4.5 V, I _D = - 1 A		0.034	0.041		
Drain-Source On-State Resistance ^a	_D	V _{GS} = - 2.5 V, I _D = - 1 A		0.040	0.048	1	
	R _{DS(on)}	V _{GS} = - 1.8 V, I _D = - 1 A		0.048	0.058	Ω	
		V _{GS} = - 1.5 V, I _D = - 1 A		0.055	0.075		
Forward Transconductance ^a	g _{fs}	V _{DS} = - 10 V, I _D = - 1 A		10.5	16	S	
Dynamic ^b			•	•	•		
Input Capacitance	C _{iss}			1600		T	
Output Capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		265		pF	
Reverse Transfer Capacitance	C _{rss}			175		1	
Total Cata Charge	0	V _{DS} = - 10 V, V _{GS} = - 5 V, I _D = - 1 A		23	35		
Total Gate Charge	Qg			22	33		
Gate-Source Charge	Q_gs	$V_{DS} = -16 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1 \text{ A}$		3.25		nC	
Gate-Drain Charge	Q _{gd}			1.95		7	
Gate Resistance	R_g	V _{GS} = - 0.1 V, f = 1 MHz		20		Ω	
Turn-On Delay Time	t _{d(on)}			15	23		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 10 Ω		29	44	ns	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 1 A, V_GEN = - 4.5 V, R_g = 1 Ω		230	345		
Fall Time	t _f			91	137		



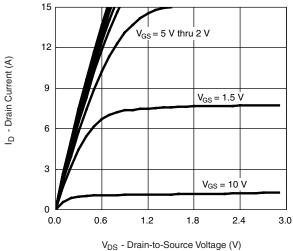


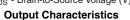
SPECIFICATIONS T _J = 25 °C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Body Diode Charac	teristics					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 5.21	А
Pulse Diode Forward Current	I _{SM}				- 15	
Body Diode Voltage	V_{SD}	I _S = - 1 A, V _{GS} = 0 V		0.6	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			116	174	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$I_F = -1 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		203	305	nC
Reverse Recovery Fall Time	t _a			45		20
Reverse Recovery Rise Time	t _b			71		ns

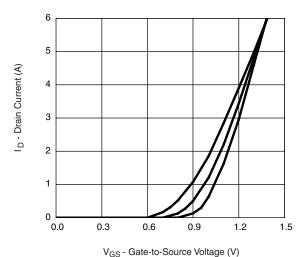
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted







VGS - Gale-10-Source vollage (V)

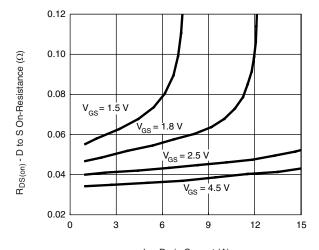
Transfer Characteristics

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

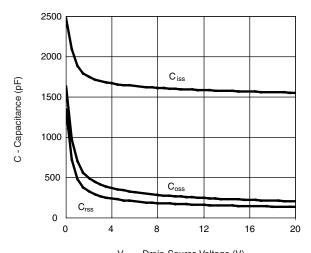
VISHAY

TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted



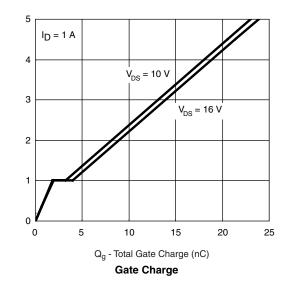
I_D - Drain Current (A)

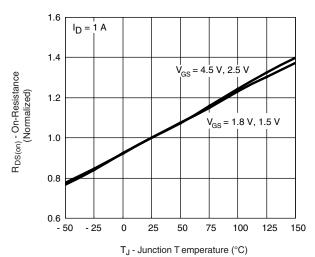
R_{DS(on)} vs. Drain Current



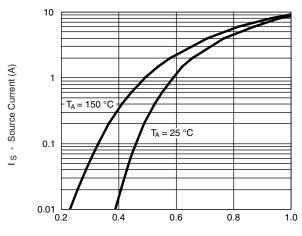
 V_{DS} - Drain-Source Voltage (V)

Capacitance



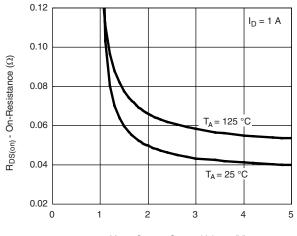


On-Resistance vs. Junction Temperature



 $V_{\mbox{SD}}$ - Source-to-Drain Voltage (V)

Forward Diode Voltage vs. Temp.



 V_{GS} - Gate-to-Source Voltage (V)

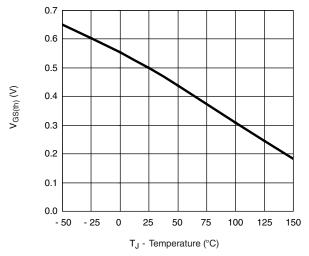
 $R_{DS(on)} \ vs. \ V_{GS} \ vs$ Temperature

V_{GS} - Gate-to-Source Voltage (V)

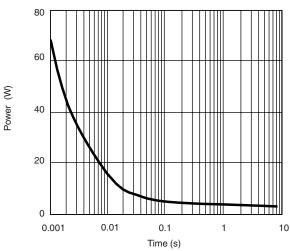




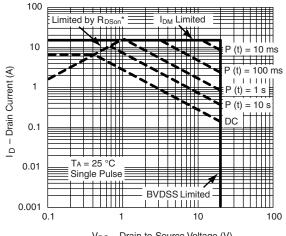
TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted



Threshold Voltage

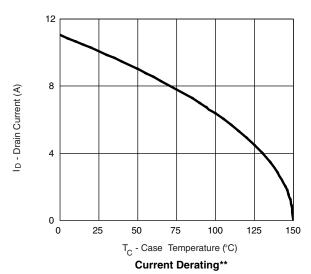


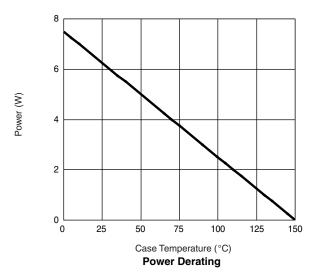
Single Pulse Power, Juncion-to-Ambient



V_{DS} - Drain-to-Source Voltage (V)

 * V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified **Safe Operating Area, Junction-to-Ambient**

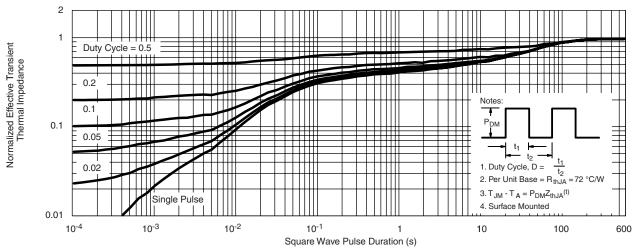




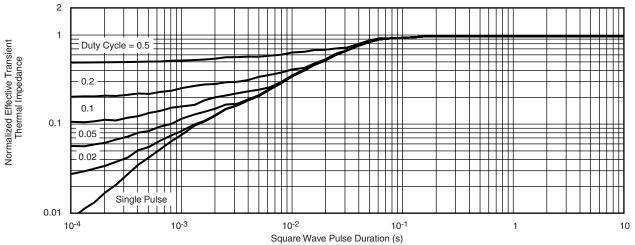
^{**} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-foot thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

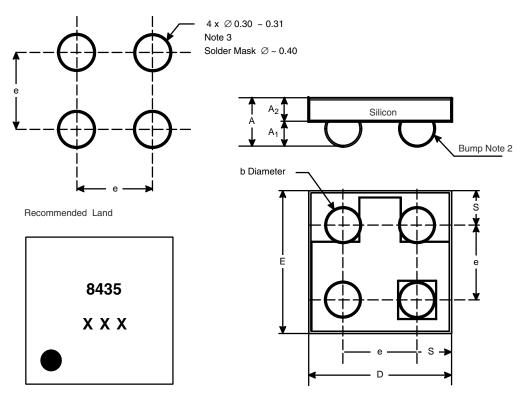


Normalized Thermal Transient Impedance, Junction-to-Foot



PACKAGE OUTLINE

MICRO FOOT: 4-BUMP (2 x 2, 0.8 mm PITCH)



Mark on Backside of Die

Notes (Unless Otherwise Specified):

- 1. Laser mark on the silicon die back, coated with a thin metal.
- 2. Bumps are Sn/Ag/Cu.
- 3. Non-solder mask defined copper landing pad.
- 4. The flat side of wafers is oriented at the bottom.

Dim.	Millim	eters ^a	Inch	es
Dilli.	Min.	Max.	Min.	Max.
Α	0.600	0.650	0.0236	0.0256
A ₁	0.260	0.290	0.0102	0.0114
A ₂	0.340	0.360	0.0134	0.0142
b	0.370	0.410	0.0146	0.0161
D	1.520	1.600	0.0598	0.0630
E	1.520	1.600	0.0598	0.0630
е	0.750	0.850	0.0295	0.0335
S	0.370	0.380	0.0146	0.0150

Notes:

a. Use millimeters as the primary measurement.

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?73559.





PCB Design and Assembly Guidelines For MICRO FOOT® Products

Johnson Zhao

INTRODUCTION

Vishay Siliconix's MICRO FOOT product family is based on a wafer-level chip-scale packaging (WL-CSP) technology that implements a solder bump process to eliminate the need for an outer package to encase the silicon die. MICRO FOOT products include power MOSFETs, analog switches, and power ICs.

For battery powered compact devices, this new packaging technology reduces board space requirements, improves thermal performance, and mitigates the parasitic effect typical of leaded packaged products. For example, the 6-bump MICRO FOOT Si8902EDB common drain power MOSFET, which measures just 1.6 mm x 2.4 mm, achieves the same performance as TSSOP-8 devices in a footprint that is 80% smaller and with a 50% lower height profile (Figure 1). A MICRO FOOT analog switch, the 6-bump DG3000DB, offers low charge injection and 1.4 W on-resistance in a footprint measuring just 1.08 mm x 1.58 mm (Figure 2).

Vishay Siliconix MICRO FOOT products can be handled with the same process techniques used for high-volume assembly of packaged surface-mount devices. With proper attention to PCB and stencil design, the device will achieve reliable performance without underfill. The advantage of the device's small footprint and short thermal path make it an ideal option for space-constrained applications in portable devices such as battery packs, PDAs, cellular phones, and notebook computers.

This application note discusses the mechanical design and reliability of MICRO FOOT, and then provides guidelines for board layout, the assembly process, and the PCB rework process.

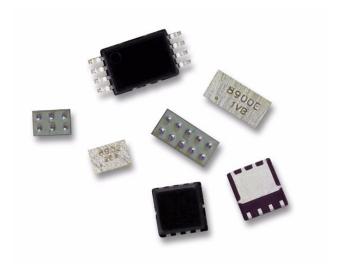


FIGURE 1. 3D View of MICRO FOOT Products Si8902DB and Si8900EDB

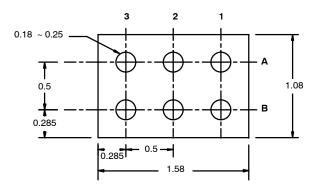


FIGURE 2. Outline of MICRO FOOT CSP & Analog Switch DG3000DB



TABLE 1 Main Parameters of Solder Bumps in MICRO FOOT Designs					
MICRO FOOT CSP Bump Material Bump Pitch* Bump Diameter* Bump Height*					
MICRO FOOT CSP MOSFET	5 0.11	0.8	0.37-0.41	0.26-0.29	
MICRO FOOT CSP Analog Switch	Eutectic Solder: 63Sm/37Pb	0.5	0.18-0.25	0.14-0.19	
MICRO FOOT UCSP Analog Switch		0.5	0.32-0.34	0.21-0.24	

^{*} All measurements in millimeters

MICRO FOOT'S DESIGN AND RELIABILITY

As a mechanical, electrical, and thermal connection between the device and PCB, the solder bumps of MICRO FOOT products are mounted on the top active surface of the die. Table 1 shows the main parameters for solder bumps used in MICRO FOOT products. A silicon nitride passivation layer is applied to the active area as the last masking process in fabrication, ensuring that the device passes the pressure pot test. A green laser is used to mark the backside of the die without damaging it. Reliability results for MICRO FOOT products mounted on a FR-4 board without underfill are shown in Table 2.

TABLE 2 MICRO FOOT Reliability Results				
Test Condition C: −65° to 150°C	>500 Cycles			
Test condition B: −40° to 125°C	>1000 Cycles			
121°C @ 15PSI 100% Humidity Test	96 Hours			

The main failure mechanism associated with wafer-level chip-scale packaging is fatigue of the solder joint. The results shown in Table 2 demonstrate that a high level of reliability can be achieved with proper board design and assembly techniques.

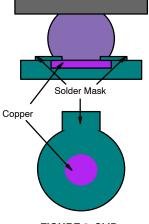


FIGURE 3. SMD

BOARD LAYOUT GUIDELINES

Board materials. Vishay Siliconix MICRO FOOT products are designed to be reliable on most board types, including organic boards such as FR-4 or polyamide boards. The package qualification information is based on the test on 0.5-oz. FR-4 and polyamide boards with NSMD pad design.

Land patterns. Two types of land patterns are used for surface-mount packages. Solder mask defined (SMD) pads have a solder mask opening smaller than the metal pad (Figure 3), whereas on-solder mask defined (NSMD) pads have a metal pad smaller than the solder-mask opening (Figure 4).

NSMD is recommended for copper etch processes, since it provides a higher level of control compared to SMD etch processes. A small-size NSMD pad definition provides more area (both lateral and vertical) for soldering and more room for escape routing on the PCB. By contrast, SMD pad definition introduces a stress -concentration point near the solder mask on the PCB side that may result in solder joint cracking under extreme fatigue conditions.

Copper pads should be finished with an organic solderability preservative (OSP) coating. For electroplated nickel-immersion gold finish pads, the gold thickness must be less than 0.5 μ m to avoid solder joint embrittlement.

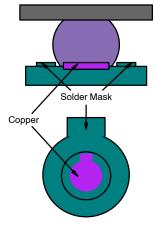


FIGURE 4. NSMD

m Document Number: 71990 06-Jan-03



Board pad design. The landing-pad size for MICRO FOOT products is determined by the bump pitch as shown in Table 3. The pad pattern is circular to ensure a symmetric, barrel-shaped solder bump.

TABLE 3 Dimensions of Copper Pad and Solder Mask Opening in PCB and Stencil Aperture					
Pitch	Pitch Copper Pad Solder Mask Stencil Aperture				
0.80 mm	0.30 ± 0.01 mm	0.41 ± 0.01 mm	0.33 ± 0.01 mm in ciircle aperture		
0.50 mm	0.17 ± 0.01 mm	0.27 ± 0.01 mm	0.30 ± 0.01 mm in square aperture		

ASSEMBLY PROCESS

MICRO FOOT products' surface-mount-assembly operations include solder paste printing, component placement, and solder reflow as shown in the process flow chart (Figure 5).



FIGURE 5. SMT Assembly Process Flow

Stencil design. Stencil design is the key to ensuring maximum solder paste deposition without compromising the assembly yield from solder joint defects (such as bridging and extraneous solder spheres). The stencil aperture is dependent on the copper pad size, the solder mask opening, and the quantity of solder paste.

In MICRO FOOT products, the stencil is 0.125-mm (5-mils) thick. The recommended apertures are shown in Table 3 and are fabricated by laser cut.

Solder-paste printing. The solder-paste printing process involves transferring solder paste through pre-defined apertures via application of pressure.

In MICRO FOOT products, the solder paste used is UP78 No-clean eutectic 63 Sn/37Pb type3 or finer solder paste.

Chip pick-and-placement. MICRO FOOT products can be picked and placed with standard pick-and-place equipment. The recommended pick-and-place force is 150 g. Though the part will self-center during solder reflow, the maximum placement offset is 0.02 mm.

Reflow Process. MICRO FOOT products can be assembled using standard SMT reflow processes. Similar to any other package, the thermal profile at specific board locations must be determined. Nitrogen purge is recommended during reflow operation. Figure 6 shows a typical reflow profile.

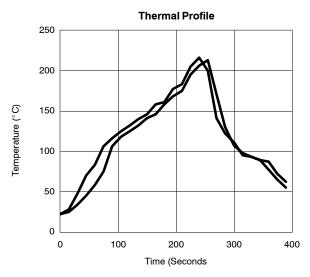


FIGURE 6. Reflow Profile

PCB REWORK

To replace MICRO FOOT products on PCB, the rework procedure is much like the rework process for a standard BGA or CSP, as long as the rework process duplicates the original reflow profile. The key steps are as follows:

- Remove the MICRO FOOT device using a convection nozzle to create localized heating similar to the original reflow profile. Preheat from the bottom.
- Once the nozzle temperature is +190°C, use tweezers to remove the part to be replaced.
- Resurface the pads using a temperature-controlled soldering iron.
- Apply gel flux to the pad.
- Use a vacuum needle pick-up tip to pick up the replacement part, and use a placement jig to placed it accurately.
- Reflow the part using the same convection nozzle, and preheat from the bottom, matching the original reflow profile.



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Revision: 02-Oct-12 Document Number: 91000